Application No.: 09/842,022 Docket No.: SON-2077

## **AMENDMENTS TO THE CLAIMS**

1. (Currently Amended) A method of forming a substrate made of a Group III-V nitride compound including at least one element from Group IIIB elements and at least nitrogen (N) from Group VB elements, wherein the substrate is grown on a growth substrate base with a thickness of smaller than or equal to 100μm, the substrate having a thickness of larger than or equal to 200μm and a curvature smaller than or equal to 0.03cm<sup>-1</sup>, the curvature being caused by a difference in thermal expansion coefficients of the growth base and the substrate.

- 2. (Original) A method of forming a substrate according to claim 1, wherein the growth base made of one selected form a group consisting of sapphire, silicon carbide, spinel, gallium arsenide and silicon is used.
- 3. (Original) A method of forming a substrate according to claim 1, wherein the substrate made of gallium nitride (GaN) is grown.
- 4. (Original) A method of forming a substrate according to claim 1, wherein the substrate is grown by means of hydride vapor phase deposition, halide vapor phase deposition or metal organic chemical vapor deposition.
- 5. (Currently Amended) A method of forming a substrate according to claim 1, wherein the substrate is grown while doping doped with impurities.
- 6. (Original) A method of forming a substrate according to claim 5, wherein at least one selected from a group consisting of carbon (C), silicon (Si), germanium (Ge), tin (Sn), sulfur (S), selenium (Se) and tellurium (Te), or at least one selected from a group consisting of carbon, silicon, germanium, tin, beryllium (Be), magnesium (Mg), calcium (Ca), zinc (Zn) and cadmium (Cd) is doped as the impurities.
- 7. (Original) A method of forming a substrate according to claim 1, further comprising a step of removing the growth base.

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8. (Original) A method of forming a substrate according to claim 7, wherein the growth base is removed by means of etching, lapping or heat application.

- 9. (Original) A method of forming a substrate according to claim 7, further comprising a step of forming a protecting film to cover the substrate prior to the step of removing the growth base.
- 10. (Original) A method of forming a substrate according to claim 1, further comprising a step of flattening a surface of the substrate.